## Notice of References Cited Application/Control No. 10/077,847 Examiner Vincent T. Tran Applicant(s)/Patent Under Reexamination LEE ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,737,931	04-1988	Ishii, Chiharu	711/157
	В	US-6,445,636	09-2002	Keeth et al.	365/222
	С	US-4,334,287	06-1982	Wiedenman et al.	710/36
	D	US-5,867,733	02-1999	Meyer, James W.	710/74
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	M	US-	*		

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R	<del>-</del>				
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	x	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.